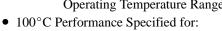


SWITCHMODE™ Series NPN Silicon Power Darlington Transistor with Base-Emitter Speedup Diode

The MJ10005 Darlington transistor is designed for high-voltage, high-speed, power switching in inductive circuits where fall time is critical. It is particularly suited for line operated switchmode applications such as:

- Switching Regulators
- Inverters
- Solenoid and Relay Drivers
- Motor Controls
- Deflection Circuits
- Fast Turn–Off Times

40 ns Inductive Fall Time — 25° C (Typ) 650 ns Inductive Storage Time — 25° C (Typ) Operating Temperature Range –65 to +200 $^{\circ}$ C

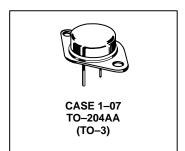


Reversed Biased SOA with Inductive Loads Switching Times with Inductive Loads Saturation Voltages Leakage Currents

MJ10005*

*ON Semiconductor Preferred Device

20 AMPERE
NPN SILICON
POWER DARLINGTON
TRANSISTORS
400 VOLTS
175 WATTS



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V _{CEO}	400	Vdc
Collector–Emitter Voltage	V _{CEX}	450	Vdc
Collector–Emitter Voltage	V _{CEV}	500	Vdc
Emitter Base Voltage	V _{EB}	8.0	Vdc
Collector Current — Continuous — Peak (1)	Ic I _{CM}	20 30	Adc
Base Current — Continuous — Peak (1)	I _B	2.5 5.0	Adc
Total Power Dissipation @ T _C = 25°C @ T _C = 100°C Derate above 25°C	P _D	175 100 1.0	Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	1.0	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 5 Seconds	TL	275	°C

(1) Pulse Test: Pulse Width = 5.0 ms, Duty Cycle ≤ 10%.

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

MJ10005

	Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERIS	STICS	•	•	'		
Collector–Emitter S (I _C = 250 mA, I _B	V _{CEO(sus)}	400	_	_	Vdc	
Collector Emitter S $(I_C = 2.0 \text{ A, V}_{clar})$ $(I_C = 10 \text{ A, V}_{clar})$	V _{CEX(sus)}	450 325		_	Vdc	
	rrent /alue, V _{BE(off)} = 1.5 Vdc) /alue, V _{BE(off)} = 1.5 Vdc, T _C = 150°C)	I _{CEV}	_	_	0.25 5.0	mAdo
Collector Cutoff Cu (V _{CE} = Rated V _C	urrent _{CEV} , R _{BE} = 50 Ω, T _C = 100°C)	I _{CER}	_	_	5.0	mAdo
Emitter Cutoff Curr (V _{EB} = 2.0 Vdc,		I _{EBO}	_	_	175	mAdo
SECOND BREAKD	OWN					
Second Breakdow	n Collector Current with base forward biased	I _{S/b}		See Fig	ure 11	
ON CHARACTERIS	TICS (2)	T		,		,
DC Current Gain ($I_C = 5.0 \text{ Adc}, V_C$ ($I_C = 10 \text{ Adc}, V_C$	h _{FE}	50 40	_ _	600 400	_	
Collector Emitter S ($I_C = 10 \text{ Adc}$, $I_B = 10 \text{ Adc}$	V _{CE(sat)}	_ _ _		1.9 3.0 2.0	Vdc	
Base Emitter Satur ($I_C = 10 \text{ Adc}, I_B = 10 \text{ Adc}, I_B = 10 \text{ Adc}$	V _{BE(sat)}	_	_	2.5 2.5	Vdc	
Diode Forward Vol (I _F = 10 Adc)	tage (1)	V _f — 3.0 5.0				Vdc
DYNAMIC CHARAC	TERISTICS	I .	Į.			1
Small–Signal Curre (I _C = 1.0 Adc, V _C	h _{fe}	10	_	_	_	
Output Capacitano (V _{CB} = 10 Vdc, I	C _{ob}	100	_	325	pF	
WITCHING CHAR						
Resistive Load (T	able 1)	1				1
Delay Time		t _d	_	0.12	0.2	μs
Rise Time	$(V_{CC} = 250 \text{ Vdc}, I_C = 10 \text{ A}, I_{B1} = 400 \text{ mA}, V_{BE(off)} = 5.0 \text{ Vdc}, t_p = 50 \mu\text{s},$	t _r	_	0.2	0.6	μs
Storage Time	Duty Cycle \leq 2%).	t _s	_	0.6	1.5	μs
Fall Time		t _f	_	0.15	0.5	μs
Inductive Load Cl	lamped (Table 1)	1	1	1		
Storage Time	$(I_C = 10 \text{ A(pk)}, V_{clamp} = \text{Rated } V_{CEX}, I_{B1} = 400 \text{ mA},$	t _{sv}	_	1.0	2.5	μs
Crossover Time	$V_{BE(off)} = 5.0 \text{ Vdc}, T_{C} = 100^{\circ}\text{C})$	t _c	_	0.4	1.5	μs
Storage Time	$(I_C = 10 \text{ A(pk)}, V_{clamp} = \text{Rated } V_{CEX}, I_{B1} = 400 \text{ mA},$	t _{sv}	_	0.65		μs
Crossover Time	$V_{BE(off)} = 5.0 \text{ Vdc}, T_{C} = 25^{\circ}C)$	t _c	-	0.2	_	μs

⁽¹⁾ The internal Collector-to-Emitter diode can eliminate the need for an external diode to clamp inductive loads. Tests have shown that the Forward Recovery Voltage (V_f) of this diode is comparable to that of typical fast recovery rectifiers.

⁽²⁾ Pulse Test: PW = 300 μ s, Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS

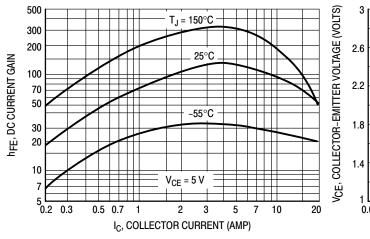
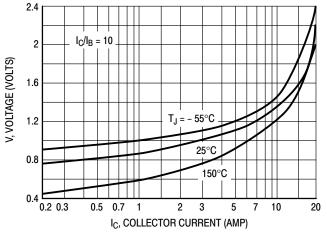


Figure 1. DC Current Gain

Figure 2. Collector Saturation Region



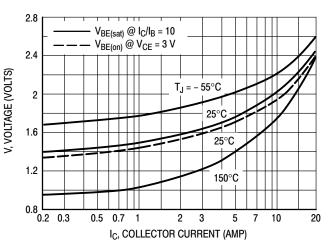
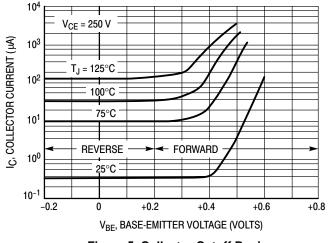


Figure 3. Collector-Emitter Saturation Voltage

Figure 4. Base-Emitter Voltage



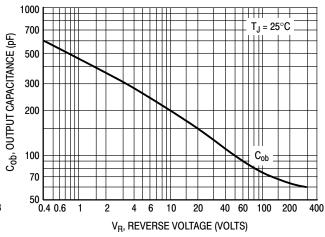


Figure 5. Collector Cutoff Region

Figure 6. Output Capacitance

Table 1. Test Conditions for Dynamic Performance

	V _{CEO(sus)}	V _{CEX(sus)} AND INDUCTIVE SWITCHING	RESISTIVE SWITCHING
INPUT	PW Varied to Attain I _C = 250 mA	SEE ABOVE FOR DETAILED CONDITIONS NA4937	
CIRCUIT	L_{coil} = 10 mH, V_{CC} = 10 V R_{coil} = 0.7 Ω V_{clamp} = $V_{CEO(sus)}$	L_{coil} = 180 μH	V_{CC} = 250 V R_L = 25 Ω Pulse Width = 50 μs
TEST CIRCUITS	INDUCTIVE TEST CIR TUT 1N4937 OR EQUIVALENT SEE ABOVE FOR DETAILED CONDITIONS Volamp 2 RS = 0.1 \(\Omega \)	CUIT OUTPUT WAVEFORMS $t_1 \text{ Adjusted to Obtain } I_C$ $t_1 \text{ Clamped}$ $t_1 = \frac{\text{Looil } (^{1}C_{pk})}{\text{V}_{CC}}$ $t_2 = \frac{\text{Looil } (^{1}C_{pk})}{\text{V}_{Clamp}}$ $t_2 = \frac{\text{Looil } (^{1}C_{pk})}{\text{V}_{Clamp}}$ $Test \text{ Equipment Scope} - Tektronix 475 \text{ or Equivalent}$	RESISTIVE TEST CIRCUIT TUT Resistive Test circuit

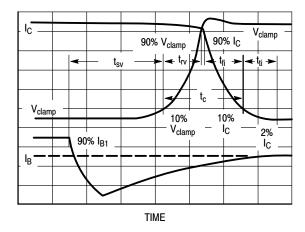


Figure 7. Inductive Switching Measurements

SWITCHING TIMES NOTE

In resistive switching circuits, rise, fall, and storage times have been defined and apply to both current and voltage waveforms since they are in phase. However, for inductive loads which are common to SWITCHMODE power supplies and hammer drivers, current and voltage waveforms are not in phase. Therefore, separate

measurements must be made on each waveform to determine the total switching time. For this reason, the following new terms have been defined.

 t_{sv} = Voltage Storage Time, 90% I_{B1} to 10% V_{clamp}

 t_{rv} = Voltage Rise Time, 10–90% V_{clamp}

 t_{fi} = Current Fall Time, 90–10% I_C

 t_{ti} = Current Tail, 10–2% I_C

 t_c = Crossover Time, 10% V_{clamp} to 10% I_C

An enlarged portion of the turn–off waveforms is shown in Figure 7 to aid in the visual identity of these terms.

For the designer, there is minimal switching loss during storage time and the predominant switching power losses occur during the crossover interval and can be obtained using the standard equation from AN–222.

$$P_{SWT} = I/2 V_{CC} I_{C} (t_{c}) f$$

In general, $t_{rv} + t_{fi} \approx t_c$. However, at lower test currents this relationship may not be valid.

As is common with most switching transistors, resistive switching is specified at 25° C and has become a benchmark for designers. However, for designers of high frequency converter circuits, the user oriented specifications which make this a "SWITCHMODE" transistor are the inductive switching speeds (t_c and t_{sv}) which are guaranteed at 100° C.

MJ10005

RESISTIVE SWITCHING PERFORMANCE

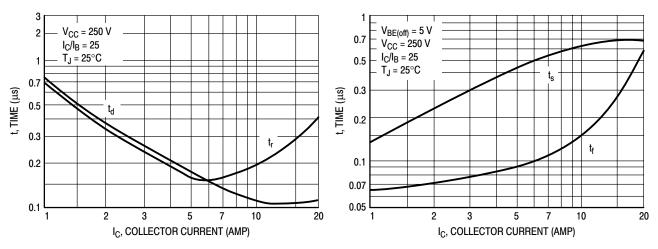


Figure 8. Turn-On Time

Figure 9. Turn-Off Time

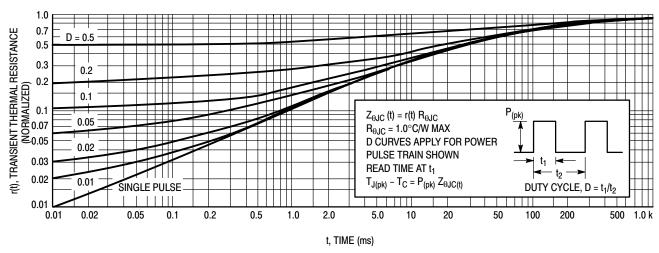


Figure 10. Thermal Response

The Safe Operating Area figures shown in Figures 11 and 12 are specified ratings for these devices under the test conditions shown.

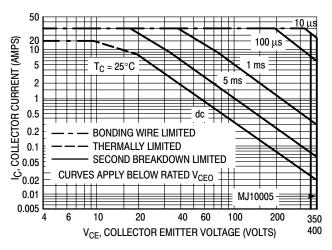


Figure 11. Forward Bias Safe Operating Area

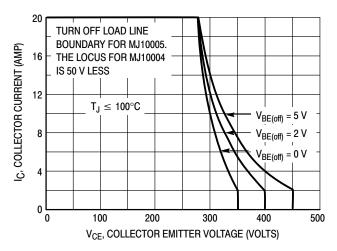


Figure 12. Reverse Bias Switching Safe Operating Area

SAFE OPERATING AREA INFORMATION

FORWARD BIAS

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 11 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C \ge 25^{\circ}C$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 11 may be found at any case temperature by using the appropriate curve on Figure 13.

 $T_{J(pk)}$ may be calculated from the data in Figure 10. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as V_{CEX(sus)} at a given collector current and represents a voltage-current condition that can be sustained during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 12 gives the complete reverse bias safe operating area characteristics.

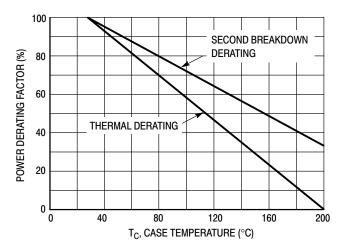
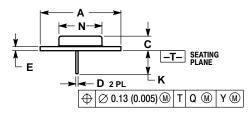


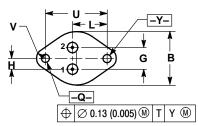
Figure 13. Power Derating

MJ10005

PACKAGE DIMENSIONS

TO-204 (TO-3) CASE 1-07 ISSUE Z





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	1.550 REF		39.37 REF	
В		1.050		26.67
С	0.250	0.335	6.35	8.51
D	0.038	0.043	0.97	1.09
E	0.055	0.070	1.40	1.77
G	0.430 BSC		10.92 BSC	
Н	0.215 BSC		5.46 BSC	
K	0.440	0.480	11.18	12.19
L	0.665 BSC		16.89 BSC	
N		0.830		21.08
Q	0.151	0.165	3.84	4.19
U	1.187 BSC 30.15		BSC	
٧	0.131	0.188	3.33	4.77

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